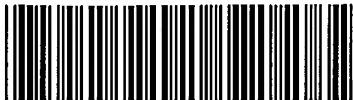


**Search Notes**

Application/Control No.

10/763,733

Examiner

Phallaka Kik

Applicant(s)/Patent under  
Reexamination

MCELHENY, PETER JOHN

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	16,18,2,7	12/23/2005	PK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS (EAST) --USPAT, USPGPUB Class/sub searched: 716/1-18 (see attached)	12/23/2005	PK
--EPO, JPO, IBM TDB, Derwent (see attached)	12/23/2005	PK
IEE/IEEE Xplore (see attached)	12/23/2005	PK